# Understanding the image contrast of material boundaries in IR nanoscopy reaching 5 nm spatial resolution 

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- Supplementary Information -
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## S1. Individual line profiles for $\mathrm{Pt} / \mathrm{Ir}$ and $\mathbf{W}$ tips



Figure S1: Two different individual s-SNOM line profiles before averaging for a) the $\mathrm{Pt} / \mathrm{Ir}$ tip and b) the W tip for demodulation orders $\mathrm{n}=2,3,4$ at 32 THz and tapping amplitude $\mathrm{A}=25 \mathrm{~nm}$.

## S2. Comparison of asymmetric vs. symmetric fit of measured line s-SNOM line profiles



Figure S2: $\mathrm{a}, \mathrm{b}$ ) Measured IR and THz near-field amplitude $\mathrm{s}_{\mathrm{n}}$ line profiles (average of 20) for harmonics $\mathrm{n}=2$ to 4 (black dots), and their respective fits using the integral of an asymmetric Lorentzian as described in text (green/blue lines). For comparison, the graphs also show a symmetric fit of the data (light blue dashed line). Tapping amplitude $\mathrm{A}=25 \mathrm{~nm}$, tip radius $\mathrm{r}=20$ nm . The curves are vertically offset for better visibility.

S3. Comparison of asymmetric vs. symmetric fit of s-SNOM line profiles measured with the W-tip


Figure S3: IR near-field amplitude $\mathrm{s}_{\mathrm{n}}$ line profiles (average of 50 ) measured with the W-tip for harmonics $\mathrm{n}=2$ to 4 (black dots), and their respective fits using the integral of an asymmetric Lorentzian as described in text (red lines). For comparison, the graphs also show a symmetric fit of the data (light blue dashed line). Tapping amplitude $\mathrm{A}=25 \mathrm{~nm}$, tip radius $\mathrm{r}=3 \mathrm{~nm}$. The curves are vertically offset for better visibility.

## S4. IR and THz line profiles without vertical offset for comparison of contrast for different demodulation orders.



Figure S4: $\mathrm{a}, \mathrm{b}$ ) Fits on near-field contrast $\mathrm{s}_{\mathrm{n}} / \mathrm{s}_{\mathrm{n}, \text { met }}$ line profiles presented in Fig. 2 for harmonics $\mathrm{n}=2$ to 4 (green/blue lines) as described in the main text. The curves are normalized to the value on metal $\mathrm{s}_{\mathrm{n}, \mathrm{met}}$ and not vertically offset to compare the near-field contrast for different harmonics. For better visibility the measured data points are not shown. Tapping amplitude $\mathrm{A}=25 \mathrm{~nm}$, tip radius $\mathrm{r}=20 \mathrm{~nm}$.

